



National Standards Authority of Ireland

IRISH STANDARD

I.S. EN 60749-18:2003

ICS 31.080.01

SEMICONDUCTOR DEVICES
MECHANICAL AND CLIMATIC TEST
METHODS
PART 18: IONIZING RADIATION (TOTAL
DOSE)
(IEC 60749-18:2002)

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EUROPEAN STANDARD

EN 60749-18

NORME EUROPÉENNE

EUROPÄISCHE NORM

February 2003

ICS 31.080.01

English version

**Semiconductor devices –
Mechanical and climatic test methods
Part 18: Ionizing radiation (total dose)
(IEC 60749-18:2002)**

Dispositifs à semiconducteurs –
Méthodes d'essais mécaniques
et climatiques
Partie 18: Rayonnements ionisants
(dose totale)
(CEI 60749-18:2002)

Halbleiterbauelemente –
Mechanische und klimatische
Prüfverfahren
Teil 18: Ionisierende Strahlung
(Gesamtdosis)
(IEC 60749-18:2002)

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CENELEC

European Committee for Electrotechnical Standardization
Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

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Foreword

The text of document 47/1657/FDIS, future edition 1 of IEC 60749-18, prepared by IEC TC 47, Semiconductor devices, was submitted to the IEC-CENELEC parallel vote and was approved by CENELEC as EN 60749-18 on 2003-02-01.

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Endorsement notice

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